CHIP COIL (CHIP INDUCTORS) LQG15HZ□□□□02D Murata Standard Reference Specification [AEC-Q200]

1.Scope

This reference specification applies to Chip coil (Chip Inductors) LQG15HZ series for Automotive Electoronics based on AEC-Q200 except for Power train and Safety.

2.Part Numbering

(ex)	LQ	_G	15	H	Z	1N0	<u>S</u>	0	2	D
	Product ID	Struture	Dimension	Applications	Category	Inductance	Tolerance	Features	Electrode	Pakaging
			$(L \times W)$	and	for Automotive					D:Taping
				Characteristics	Electoronics					

3.Rating

Operating Temperature Range. −55°C to +125°C
 Storage Temperature Range. −55°C to +125°C

Customer Part Number	MURATA Part Number	Inductance (nH)	Tolerance	Q (min.)	DC Resistance (Ω max.)	Self Resonant Frequency (MHz min.)	Rated Current (mA)	ESD Rank 1C:1kV		
			(*1)(refe	er to belo	w comment)					
	LQG15HZ1N0B02D									
	LQG15HZ1N0C02D	1.0				10000				
	LQG15HZ1N0S02D									
	LQG15HZ1N1B02D									
	LQG15HZ1N1C02D	1.1								
	LQG15HZ1N1S02D									
	LQG15HZ1N2B02D									
	LQG15HZ1N2C02D	1.2								
	LQG15HZ1N2S02D				0.07		1000			
	LQG15HZ1N3B02D				0.07		1000			
	LQG15HZ1N3C02D	1.3								
	LQG15HZ1N3S02D									
	LQG15HZ1N5B02D									
	LQG15HZ1N5C02D	1.5								
	LQG15HZ1N5S02D									
	LQG15HZ1N6B02D									
	LQG15HZ1N6C02D	1.6								
	LQG15HZ1N6S02D									
	LQG15HZ1N8B02D		B:±0.1nH							
	LQG15HZ1N8C02D	1.8	C:±0.2nH	8	0.08		950	1C		
	LQG15HZ1N8S02D		S:±0.3nH			0000				
	LQG15HZ2N0B02D					6000				
	LQG15HZ2N0C02D	2.0								
	LQG15HZ2N0S02D									
	LQG15HZ2N2B02D				0.09		900			
	LQG15HZ2N2C02D	2.2								
	LQG15HZ2N2S02D	1								
	LQG15HZ2N4B02D					1		1		
	LQG15HZ2N4C02D	2.4			0.11		850			
	LQG15HZ2N4S02D	1								
	LQG15HZ2N7B02D					1		1		
	LQG15HZ2N7C02D	2.7			0.12					
	LQG15HZ2N7S02D	1								
	LQG15HZ3N0B02D		1			1				
	LQG15HZ3N0C02D	3.0					800			
	LQG15HZ3N0S02D	1 0.0								
	LQG15HZ3N3B02D		1		0.125					
	LQG15HZ3N3C02D	3.3								
	LQG15HZ3N3S02D	5.5								

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Customer Part Number	MURATA Part Number	Inductance (nH)	Tolerance	Q (min.)	DC Resistance (Ω max.)	Self Resonant Frequency (MHz min.)	Rated Current (mA)	ESD Rank 1C:1kV
	LQG15HZ3N6B02D		(1)(1010	1 10 501	JW COMMITCHLY			
	LQG15HZ3N6C02D	3.6						
	LQG15HZ3N6S02D							
	LQG15HZ3N9B02D							
	LQG15HZ3N9C02D	3.9			0.14		750	
	LQG15HZ3N9S02D					0000		
	LQG15HZ4N3B02D					6000		
	LQG15HZ4N3C02D	4.3						
	LQG15HZ4N3S02D							
	LQG15HZ4N7B02D		B:±0.1nH					
	LQG15HZ4N7C02D	4.7	C:±0.2nH		0.16		700	
	LQG15HZ4N7S02D		S:±0.3nH					
	LQG15HZ5N1B02D							
	LQG15HZ5N1C02D	5.1				5300		
	LQG15HZ5N1S02D				0.10		050	
	LQG15HZ5N6B02D				0.18		650	
	LQG15HZ5N6C02D	5.6						
	LQG15HZ5N6S02D							
	LQG15HZ6N2B02D		1					
	LQG15HZ6N2C02D	6.2			0.20	4500		
	LQG15HZ6N2S02D	- 0.2			0.20	1000		
	LQG15HZ6N8G02D					-	600	
	LQG15HZ6N8H02D	6.8			0.22			
	LQG15HZ6N8J02D	1 0.0			0.22			
	LQG15HZ7N5G02D							
	LQG15HZ7N5H02D	7.5				4200		
	LQG15HZ7N5J02D	1 7.5				4200		
	LQG15HZ8N2G02D		1	8	0.24		550	1C
	LQG15HZ8N2H02D	8.2				3700		
	LQG15HZ8N2J02D	- 0.2				3700		
	LQG15HZ9N1G02D							
	LQG15HZ9N1H02D	9.1						
	LQG15HZ9N1J02D	- 5.'						
	LQG15HZ10NG02D		†		0.26	3400		
	LQG15HZ10NH02D	10					500	
	LQG15HZ10NJ02D	10					300	
	LQG15HZ12NG02D		G:±2%					
	LQG15HZ12NH02D	12	H:±3%		0.28	3000		
	LQG15HZ12NJ02D	- '-	J:±5%		0.20	3000		
	LQG15HZ15NG02D		0.2070					
	LQG15HZ15NG02D	15			0.32	2500	450	
		- 15			0.32	2500	430	
	LQG15HZ15NJ02D LQG15HZ18NG02D							
	LQG15HZ18NH02D	18			0.36	2200	400	
	LQG15HZ18NJ02D	- 10			0.36	2200	400	
	+		-					1
	LQG15HZ22NG02D LQG15HZ22NH02D	22			0.42	1900		
		- 22			0.42	1900		
	LQG15HZ22NJ02D		1					
	LQG15HZ27NG02D	07			0.40	1700	250	
	LQG15HZ27NH02D	27			0.46	1700	350	
	LQG15HZ27NJ02D		1					
	LQG15HZ33NG02D				0.50	4000		
_	LQG15HZ33NH02D	33			0.58	1600		
	LQG15HZ33NJ02D	1						<u> </u>

Customer Part Number	MURATA Part Number	Inductance (nH)	Tolerance	Q (min.)	DC Resistance (Ω max.)	Self Resonant Frequency (MHz min.)	Rated Current (mA)	ESD Rank 1C:1kV
			(*1)(refe	er to belo	w comment)			
	LQG15HZ39NG02D							
	LQG15HZ39NH02D	39			0.65	1200		
	LQG15HZ39NJ02D						300	
	LQG15HZ47NG02D						000	
	LQG15HZ47NH02D	47			0.72	1000		
	LQG15HZ47NJ02D							
	LQG15HZ56NG02D							
	LQG15HZ56NH02D	56			0.82			
	LQG15HZ56NJ02D					800	250	
	LQG15HZ68NG02D					800	230	
	LQG15HZ68NH02D	68			0.92			
	LQG15HZ68NJ02D							
	LQG15HZ82NG02D							
	LQG15HZ82NH02D	82			1.20	700		
	LQG15HZ82NJ02D							
	LQG15HZR10G02D		G:±2%					
	LQG15HZR10H02D	100	H:±3%	8	1.25		200	1C
	LQG15HZR10J02D	1	J:±5%			600		
	LQG15HZR12G02D					600		
	LQG15HZR12H02D	120			1.30			
	LQG15HZR12J02D							
	LQG15HZR15G02D							
	LQG15HZR15H02D	150			2.99	550		
	LQG15HZR15J02D						450	
	LQG15HZR18G02D						150	
	LQG15HZR18H02D	180			3.38	500		
	LQG15HZR18J02D							
	LQG15HZR22G02D							
	LQG15HZR22H02D	220			3.77	450	120	
	LQG15HZR22J02D	1						
	LQG15HZR27G02D							
	LQG15HZR27H02D	270			4.94	400	110	
	LQG15HZR27J02D	1						

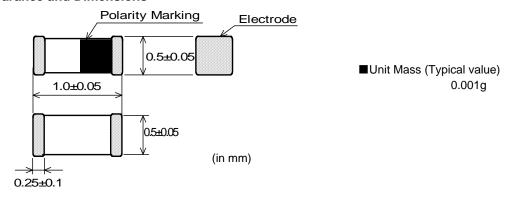
(*1) Standard Testing Conditions

《Unless otherwise specified》 《In case of doubt》

Humidity : Ordinary Humidity / 25%(RH) to 85%(RH) Humidity : 60%(RH) to 70%(RH)

Atmospheric Pressure: 86kPa to 106 kPa

4. Appearance and Dimensions



SpecNo.JELF243B-9110C-01

Reference Only

5.Electrical Performance

No.	Item	Specification	Test Method
5.1	Inductance	Inductance shall meet item 3.	Measuring Equipment: KEYSIGHT 4291A or equivalent Measuring Frequency:100MHz Measuring Condition: Test signal level/about 7dBm Electricallength/0.94cm Weight/about 1N to 5N Measuring Fixture: KEYSIGHT 16193A Position coil under test as shown in below and contact coil with each terminal by adding weight. Polarity marking should be a topside,and polarity marking should be in the direction of the fixture for position of chip coil.
5.2	Q	Q shall meet item 3.	Polarity Marking 11.5mm Measuring Method:See the endnote [Electrical Performance:Measuring Method of Inductance/Q]
5.3	DC Resistance	DC Resistance shall meet item 3.	Measuring Equipment:Digital multi meter
5.4	Self Resonant Frequency(S.R.F)	S.R.F shall meet item 3.	Measuring Equipment: KEYSIGHT 8753C or equivalent
5.5	Rated Current	Self temperature rise shall be limited to 25°C max.	The allowable current is applied.

6.Q200 Requirement

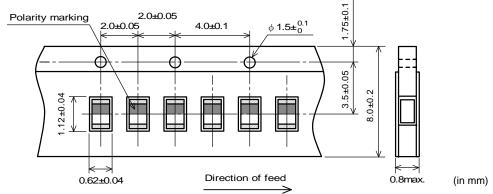
6.1.Performance (based on Table 5 for Magnetics(Inductors / Transformer)

AEC-Q200 Rev.D issued June 1. 2010

		AEC-Q200	Murata Specification / Deviation			
No			- Indiana opeomeanon, zenanon			
	High Temperature Exposure	1000hours at 125 deg C Set for 24hours at room temperature, then measured.	Meet Table A after testing. Table A Appearance No damage Inductance Change (at 100MHz) Within ±10%			
4	Temperature Cycling	1000cycles -40 deg C to +125 deg C Set for 24hours at room temperature,then measured.	Meet Table A after testing.			
	Biased Humidity	1000hours at 85 deg C, 85%RH unpowered.				
8	Operational Life	Apply 125 deg C 1000hours Set for 24hours at room temperature, then measured	Meet Table A after testing.			
	External Visual	Visual inspection	No abnormalities			
10	Physical Dimension	Meet ITEM 4 (Style and Dimensions)	No defects			
	Resistance to Solvents	Per MIL-STD-202 Method 215	Not Applicable			
13	Mechanical Shock	Per MIL-STD-202 Method 213 Condition C : 100g's(0.98N), 6ms, Half sine, 12.3ft/s	Meet Table A after testing.			
14	Vibration	5g's(0.049N) for 20 minutes, 12cycles each of 3 oritentations Test from 10-2000Hz.	Meet Table A after testing.			
_	Resistance to Soldering Heat	No-heating Solder temperature 260C+/-5 deg C Immersion time 10s	Meet Table A after testing. Pre-heating 150C +/-10 deg C, 60s to 90s			
17	ESD	Per AEC-Q200-002	ESD Rank: refer to the Item3 (Rating). Meet Table A after testing			
18	Solderbility	Per J-STD-002	Method b : Not Applicable 90% of the terminations is to be soldered.			
	Characterization	Measured : Inductance	No defects			
	Flammability	Per UL-94	Not Applicable			
21	Board Flex	Epoxy-PCB(1.6mm) Deflection 2mm(min) Holding time 60s	Meet Table B after testing. Table B Appearance No damage DC resistance Change Within ±10%			
22		Per AEC-Q200-006 A force of 17.7N for 60s	Murata Deviation Request: 5N No defects			

7. Specification of Packaging

7.1 Appearance and Dimensions of paper tape (8mm-wide)



7.2 Specification of Taping

(1) Packing quantity (standard quantity)

10,000 pcs. / reel

(2) Packing Method

Products shall be packed in the cavity of the base tape and sealed by top tape and bottom tape.

(3) Sprocket hole

The sprocket holes are to the right as the tape is pulled toward the user.

(4) Spliced point

Base tape and Top tape has no spliced point.

(5) Missing components number

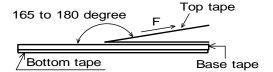
Missing components number within 0.1 % of the number per reel or 1 pc., whichever is greater, and are not continuous. The Specified quantity per reel is kept.

7.3 Pull Strength

Top tape	5N min.
Bottom tape	OIN IIIIII.

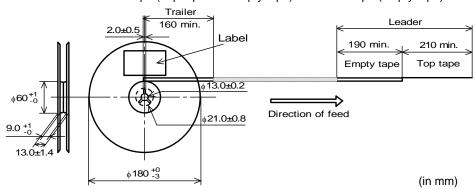
7.4 Peeling off force of cover tape

Speed of Peeling off	300mm/min
Peeling off force	0.1N to 0.6N
	(minimum value is typical)



7.5 Dimensions of Leader-tape, Trailer and Reel

There shall be leader-tape (top tape and empty tape) and trailer-tape (empty tape) as follows.



Referenc<u>e Only</u>

7.6 Marking for reel

Customer part number, MURATA part number, Inspection number(*1), RoHS Marking(*2), Quantity etc · · ·

*1) < Expression of Inspection No.>

□□ <u>0000</u> <u>×××</u>

(1) Factory Code

(2) Date First digit : Year / Last digit of year

Second digit: Month / Jan. to Sep. \rightarrow 1 to 9, Oct. to Dec. \rightarrow O, N, D

Third, Fourth digi: Day

(3) Serial No.

*2) < Expression of RoHS Marking>

 $ROHS - \underline{Y}(\underline{\Delta})$ (1)(2)

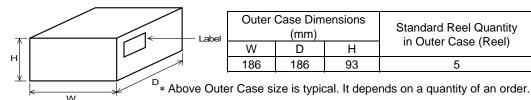
(1) RoHS regulation conformity parts.

(2) MURATA classification number

7.7 Marking for Outside package (corrugated paper box)

Customer name, Purchasing order number, Customer part number, MURATA part number, RoHS Marking(*2) ,Quantity, etc · · ·

7.8. Specification of Outer Case



Outer Case Dimensions (mm)			Standard Reel Quantity	
W	D	Н	in Outer Case (Reel)	
186	186	93	5	

8. A Caution

8.1 Caution(Rating)

Do not exceed maximum rated current of the product. Thermal stress may be transmitted to the product and short/open circuit of the product or falling off the product may be occurred.

8.2 Fail-safe

Be sure to provide an appropriate fail-safe function on your product to prevent a second damage that may be caused by the abnormal function or the failure of our product.

8.3 Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

(1) Aircraft equipment

(2) Aerospace equipment

(3) Undersea equipment Power plant control equipment

(5) Medical equipment

(6) Transportation equipment (trains, ships, etc.)

(7) Traffic signal equipment

Disaster prevention / crime prevention equipment (8)

(9) Data-processing equipment (10) Applications of similar complexity and /or reliability requirements to the applications listed in the above

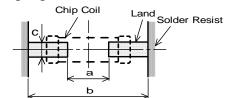
9. Notice

Products can only be soldered with reflow.

This product is designed for solder mounting.

Please consult us in advance for applying other mounting method such as conductive adhesive.

9.1 Land pattern designing



a	0.4
b	1.4 to 1.5
С	0.5 to 0.6

(in mm)

9.2 Flux, Solder

·Use rosin-based flux.

Don't use highly acidic flux with halide content exceeding 0.2(wt)% (chlorine conversion value). Don't use water-soluble flux.

- •Use Sn-3.0Ag-0.5Cu solder.
- •Standard thickness of solder paste : 100 μ m to 150 μ m.

9.3 Reflow soldering conditions

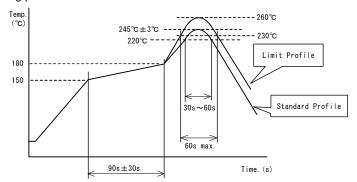
- Inductance value may be changed a little due to the amount of solder.
- So, the chip coil shall be soldered by reflow so that the solder volume can be controlled.
- •Pre-heating should be in such a way that the temperature difference between solder and product surface is limited to 150°C max. Cooling into solvent after soldering also should be in such a way that the temperature difference is limited to 100°C max.

Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of products quality.

·Standard soldering profile and the limit soldering profile is as follows.

The excessive limit soldering conditions may cause leaching of the electrode and / or resulting in the deterioration of product quality.

·Reflow soldering profile



	Standard Profile	Limit Profile
Pre-heating	150°C~180°	C 、90s±30s
Heating	above 220°C, 30s∼60s	above 230°C, 60s max.
Peak temperature	245°C±3°C	260°C,10s
Cycle of reflow	2 times	2 times

9.4 Reworking with soldering iron

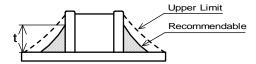
The following conditions must be strictly followed when using a soldering iron.

Pre-heating	150°C,1 min
Tip temperature	350°C max.
Soldering iron output	80W max.
Tip diameter	¢3mm max.
Soldering time	3(+1,-0)s
Time	2 times

Note :Do not directly touch the products with the tip of the soldering iron in order to prevent the crack on the products due to the thermal shock.

9.5 Solder Volume

- · Solder shall be used not to be exceed the upper limits as shown below.
- Accordingly increasing the solder volume, the mechanical stress to Chip is also increased.
 Exceeding solder volume may cause the failure of mechanical or electrical performance.



1/3T≦t≦T T:thickness of product



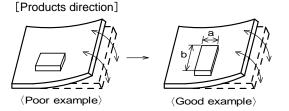
9.6 Mount Shock

Over Mechanical stress to products at mounting process causes crack and electrical failure etc.

9.7 Product's location

The following shall be considered when designing and laying out P.C.B.'s.

(1) P.C.B. shall be designed so that products are not subjected to the mechanical stress due to warping the board.



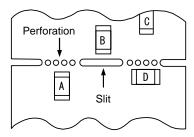
Products shall be located in the sideways direction (Length:a < b) to the mechanical stress.

(2) Components location on P.C.B. separation.

It is effective to implement the following measures, to reduce stress in separating the board.

It is best to implement all of the following three measures; however, implement as many measures as possible to reduce stress.

Contents of Measures	Stress Level
(1) Turn the mounting direction of the component parallel to the board separation surface.	A > D*1
(2) Add slits in the board separation part.	A > B
(3) Keep the mounting position of the component away from the board separation surface.	A > C

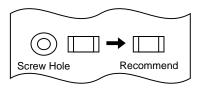


*1 A > D is valid when stress is added vertically to the perforation as with Hand Separation.

If a Cutting Disc is used, stress will be diagonal to the PCB, therefore A > D is invalid.

(3) Mounting Components Near Screw Holes

When a component is mounted near a screw hole, it may be affected by the board deflection that occurs during the tightening of the screw. Mount the component in a position as far away from the screw holes as possible.



9.8 Cleaning Conditions

Products shall be cleaned on the following conditions.

- (1) Cleaning temperature shall be limited to 60°C max.(40°C max for IPA.)
- (2) Ultrasonic cleaning shall comply with the following conditions with avoiding the resonance phenomenon at the mounted products and P.C.B.

Power: 20 W / I max. Frequency: 28kHz to 40kHz Time: 5 min max.

- (3) Cleaner
 - Alcohol type cleaner Isopropyl alcohol (IPA)
 - 2. Aqueous agent PINE ALPHA ST-100S
- (4) There shall be no residual flux and residual cleaner after cleaning. In the case of using aqueous agent, products shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- (5) Other cleaning Please contact us.

9.9 Resin coating

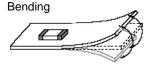
The inductance value may change and/or it may affect on the product's performance due to high cure-stress of resin to be used for coating / molding products. So please pay your careful attention when you select resin.

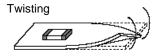
In prior to use, please make the reliability evaluation with the product mounted in your application set.

9.10 Handling of a substrate

After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

Excessive mechanical stress may cause cracking in the product.





9.11 Storage and Handling Requirements

(1) Storage period

Use the products within 6 months after deliverd.

Solderability should be checked if this period is exceeded.

- (2) Storage conditions
 - Products should be stored in the warehouse on the following conditions.

Temperature: -10°C to 40°C

Humidity: 15% to 85% relative humidity No rapid change on temperature and humidity

Don't keep products in corrosive gases such as sulfur, chlrine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.

- Products should be storaged on the palette for the prevention of the influence from humidity, dust and so on.
- Products should be storaged in the warehouse without heat shock, vibration, direct sunlight and so on.
- Products should be storaged under the airtight packaged condition.
- (3) Handling Condition

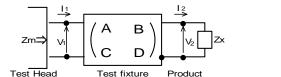
Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

10 ▲ Note

- (1) Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2) You are requested not to use our product deviating from the reference specifications.
- (3) The contents of this reference specification are subject to change without advance notice. Please approve our product specifications or transact the approval sheet for product specifications before ordering.

-<Electrical Performance:Measuring Method of Inductance/Q>-

(1) Residual elements and stray elements of test fixture can be described by F-parameter shown in following.



(2) The impedance of chip coil Zx and measured value Zm can be described by input/output current/voltage.

$$Zm = \frac{V_1}{I_1}$$
 , $Zx = \frac{V_2}{I_2}$

(3) Thus, the relation between Zx and Zm is following;

$$Z = \alpha \frac{Zm - \beta}{1 - Zm \Gamma}$$
 where, $\alpha = D / A = 1$
 $\beta = B / D = Zsm - (1 - Yom Zsm)Zss$
 $\Gamma = C / A = Yom$

Zsm:measured impedance of short chip Zss:residual impedance of short chip (0nH) Yom:measured admittance when opening the fixture

 $\left[\begin{array}{c} V_1 \\ I_1 \end{array} \right] = \left[\begin{array}{cc} A & B \\ C & D \end{array} \right] \left[\begin{array}{c} V_2 \\ I_2 \end{array} \right]$

(4) Lx and Qx shall be calculated with the following equation.

$$Lx = \frac{Im(Zx)}{2\pi f}, \quad Qx = \frac{Im(Zx)}{Re(Zx)}$$

$$Lx : Inductance of chip coil$$

$$Qx : Q of chip coil$$

$$f : Measuring frequency$$